

Notice of References Cited	Application/Control No. 10/814,933	Applicant(s)/Patent Under Reexamination BUCHAN ET AL.	
	Examiner Connie P. Johnson	Art Unit 1752	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,457,081	10-1995	Takiguchi et al.	503/227
*	B	US-6,261,995	07-2001	Nakajima et al.	503/227
*	C	US-4,736,048	04-1988	Brown et al.	556/454
*	D	US-5,578,545	11-1996	Fujimura et al.	503/227
*	E	US-5,254,523	10-1993	Fujimura et al.	503/227
*	F	US-6,037,092	03-2000	Heeks et al.	430/124
*	G	US-5,452,658	09-1995	Shell, Richard S.	101/401.1
*	H	US-6,556,380	04-2003	Bunch et al.	360/235.1
*	I	US-6,225,409	05-2001	Davis et al.	525/104
*	J	US-6,252,741	06-2001	Ahn, Junghi	360/235.1
*	K	US-6,676,996	01-2004	Pickering et al.	427/365
*	L	US-2005/0091836 A1	05-2005	Hwang et al.	029/603.07
*	M	US-6,725,526	04-2004	Lille, Jeffrey S.	29/603.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1079275 A2	02-2001	European Patent	OHNO et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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